IXYS

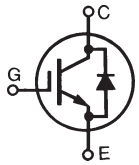
Advance Technical Information

High Voltage XPT™ IGBT w/ Diode

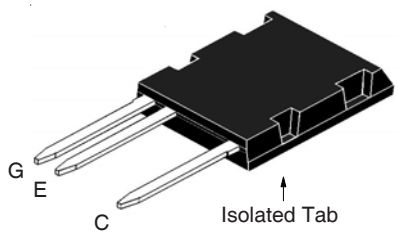
IXYL50N170CV1

V_{CES} = 1700V
I_{C110} = 46A
$V_{CE(sat)}$ ≤ 3.7V
$t_{fi(typ)}$ = 95ns

(Electrically Isolated Tab)



ISOPLUS i5-Pak™



G = Gate E = Emitter
C = Collector

Symbol	Test Conditions	Maximum Ratings	
V_{CES}	T_J = 25°C to 175°C	1700	V
V_{CGR}	T_J = 25°C to 175°C, R_{GE} = 1MΩ	1700	V
V_{GES}	Continuous	±20	V
V_{GEM}	Transient	±30	V
I_{C25}	T_C = 25°C	90	A
I_{C110}	T_C = 110°C	46	A
I_{F110}	T_C = 110°C	26	A
I_{CM}	T_C = 25°C, 1ms	325	A
SSOA (RBSOA)	V_{GE} = 15V, T_{VJ} = 150°C, R_G = 1Ω	I_{CM} = 200	A
	Clamped Inductive Load	1360	V
P_C	T_C = 25°C	580	W
T_J		-55 ... +175	°C
T_{JM}		175	°C
T_{stg}		-55 ... +175	°C
T_L	Maximum Lead Temperature for Soldering	300	°C
T_{SOLD}	1.6 mm (0.062in.) from Case for 10s	260	°C
F_C	Mounting Force	40..120 / 9..27	N/lb
V_{ISOL}	50/60 Hz, RM, t = 1min	2500	V~
Weight		8	g

Symbol	Test Conditions (T_J = 25°C, Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
BV_{CES}	I_C = 250μA, V_{GE} = 0V	1700			V
$V_{GE(th)}$	I_C = 250μA, V_{CE} = V_{GE}	3.0		5.0	V
I_{CES}	V_{CE} = V_{CES}, V_{GE} = 0V			25	μA
	V_{CE} = 0.8 • V_{CES} T_J = 125°C			5	mA
I_{GES}	V_{CE} = 0V, V_{GE} = ±20V			±100	nA
$V_{CE(sat)}$	I_C = 50A, V_{GE} = 15V, Note 1		2.8	3.7	V
	T_J = 150°C		3.9		V

Features

- Silicon Chip on Direct-Copper Bond (DCB) Substrate
- Isolated Mounting Surface
- 4500V~ Electrical Isolation
- High Voltage Package
- High Blocking Voltage
- High Peak Current Capability
- Low Saturation Voltage

Advantages

- Low Gate Drive Requirement
- High Power Density

Applications

- UPS
- Motor Drives
- SMPS
- PFC Circuits
- High Frequency Power Inverters

Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
g_{fs}	I_C = 50A, V_{CE} = 10V, Note 1	30	50		S
R_{Gi}	Gate Input Resistance		2.0		Ω
C_{ies}	V_{CE} = 25V, V_{GE} = 0V, f = 1MHz		5500		pF
C_{oes}			380		pF
C_{res}			105		pF
$Q_{g(on)}$	I_C = 50A, V_{GE} = 15V, V_{CE} = 0.5 • V_{CES}		260		nC
Q_{ge}			28		nC
Q_{gc}			110		nC
$t_{d(on)}$	**Inductive load, T_J = 25°C**		20		ns
t_{ri}	I_C = 50A, V_{GE} = 15V		44		ns
E_{on}	V_{CE} = 0.5 • V_{CES}, R_G = 1Ω		8.7		mJ
$t_{d(off)}$	Note 2		180		ns
t_{fi}			95		ns
E_{off}			5.6		mJ
$t_{d(on)}$	**Inductive load, T_J = 150°C**		22		ns
t_{ri}	I_C = 50A, V_{GE} = 15V		40		ns
E_{on}	V_{CE} = 0.5 • V_{CES}, R_G = 1Ω		11.9		mJ
$t_{d(off)}$	Note 2		236		ns
t_{fi}			160		ns
E_{off}			8.2		mJ
R_{thJC}				0.26	°C/W
R_{thCS}			0.15		°C/W

Reverse Sonic Diode (FRD)

Symbol	Test Conditions (T_J = 25°C Unless Otherwise Specified)	Characteristic Values Min.	Typ.	Max.	
V_F	I_F = 50A, V_{GE} = 0V, Note 1		2.5	3.2	V
	T_J = 150°C		3.2		V
I_{RM}	I_F = 50A, V_{GE} = 0V, T_J = 150°C		40		A
t_{rr}	$-di_F/dt$ = 500A/μs, V_R = 1200V		255		ns
R_{thJC}				0.83	°C/W

Notes:

1. Pulse test, t ≤ 300μs, duty cycle, d ≤ 2%.
2. Switching times & energy losses may increase for higher V_{CE}(Clamp), T_J or R_G.

ADVANCE TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from a subjective evaluation of the design, based upon prior knowledge and experience, and constitute a "considered reflection" of the anticipated result. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

Fig. 1. Output Characteristics @ T_J = 25°C

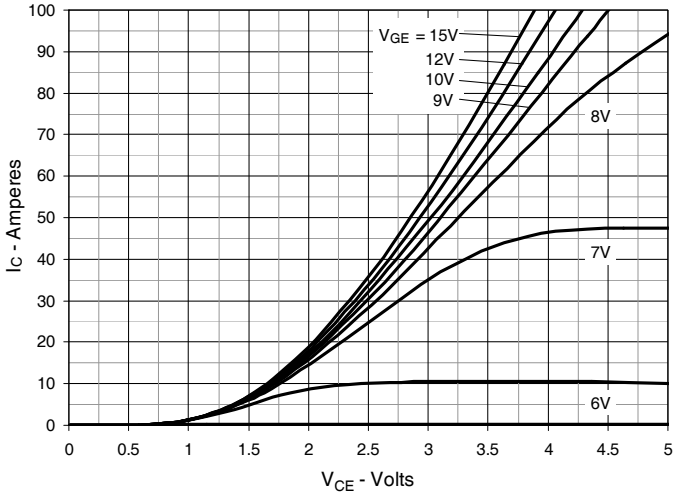


Fig. 2. Extended Output Characteristics @ T_J = 25°C

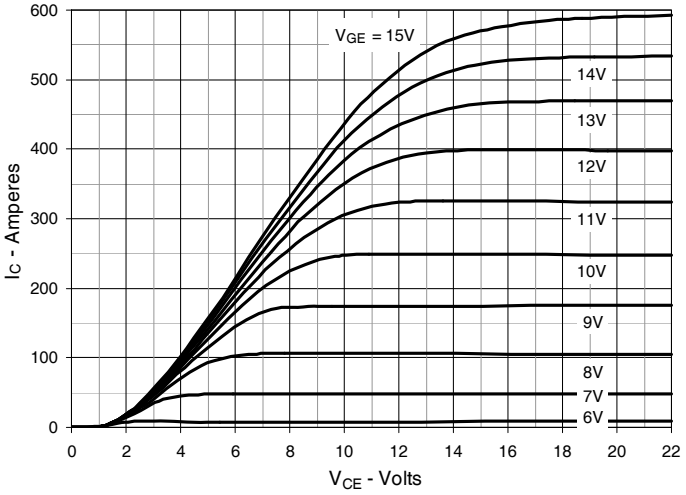


Fig. 3. Output Characteristics @ T_J = 150°C

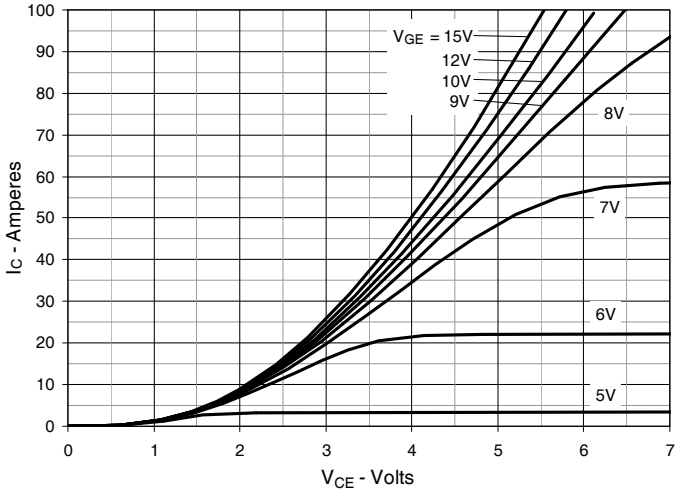


Fig. 4. Dependence of $V_{CE(sat)}$ on Junction Temperature

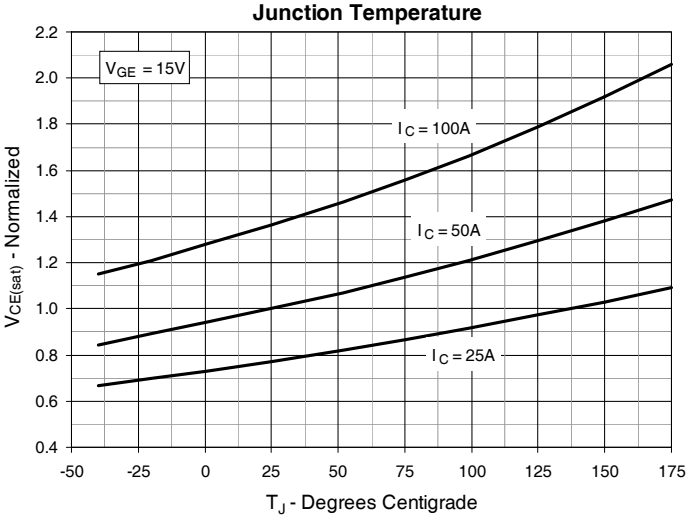


Fig. 5. Collector-to-Emitter Voltage vs. Gate-to-Emitter Voltage

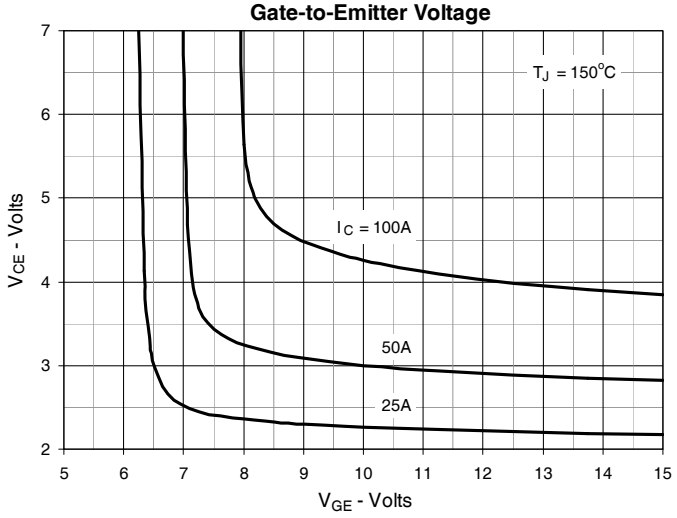


Fig. 6. Input Admittance

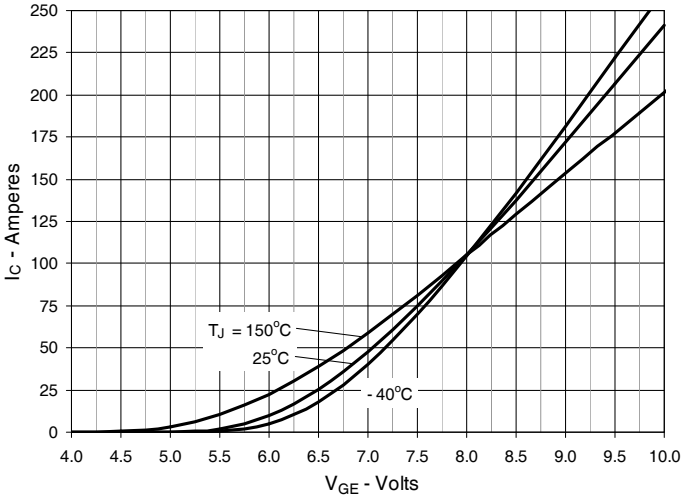


Fig. 7. Transconductance

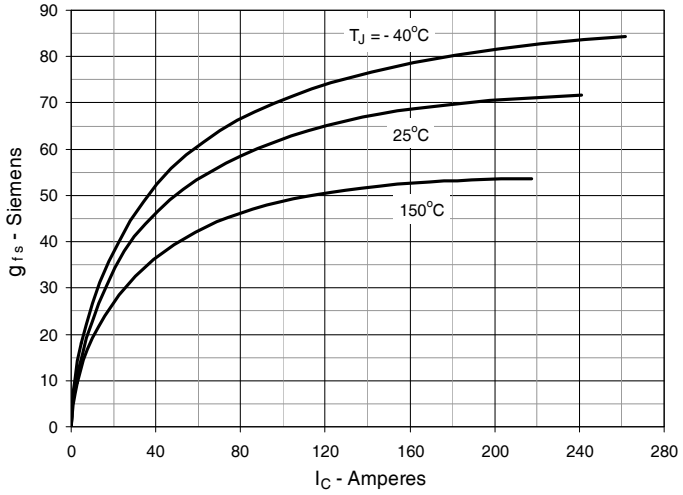


Fig. 8. Gate Charge

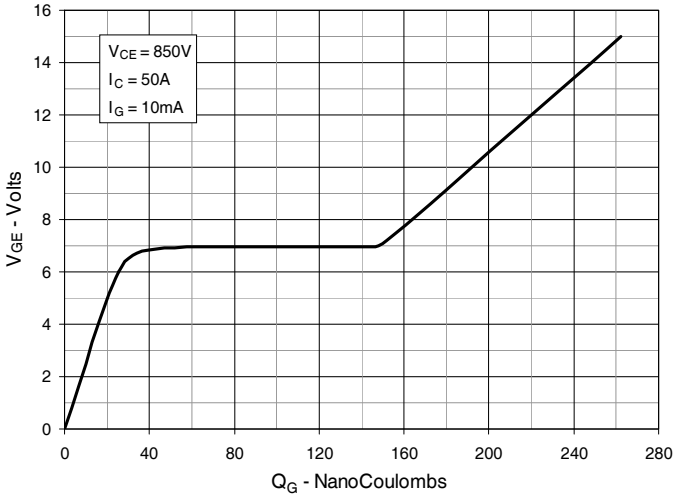


Fig. 9. Capacitance

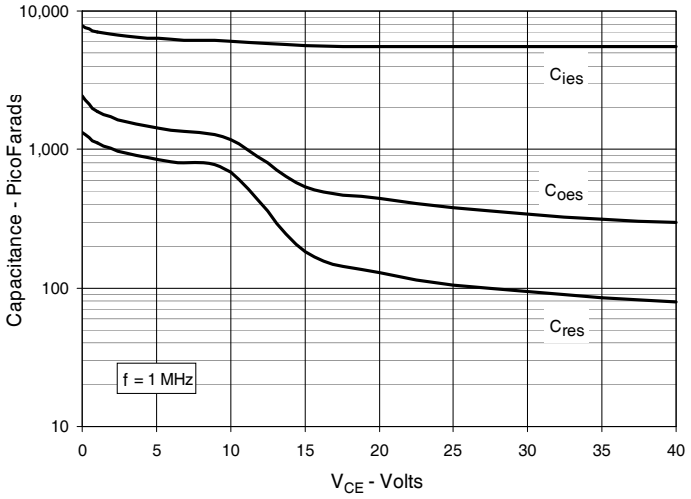


Fig. 10. Reverse-Bias Safe Operating Area

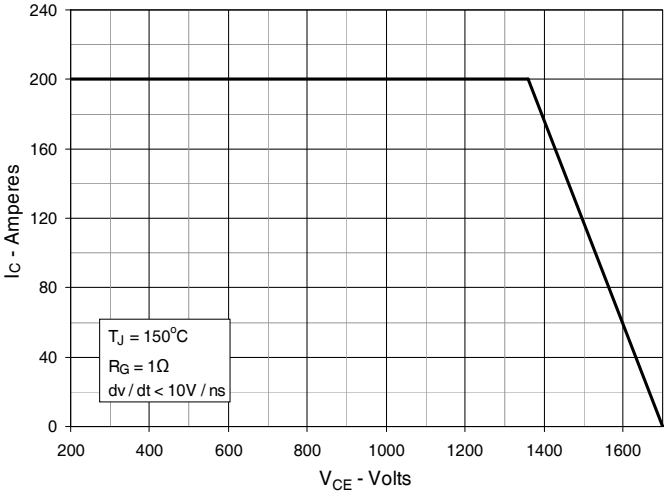


Fig. 11. Maximum Transient Thermal Impedance (IGBT)

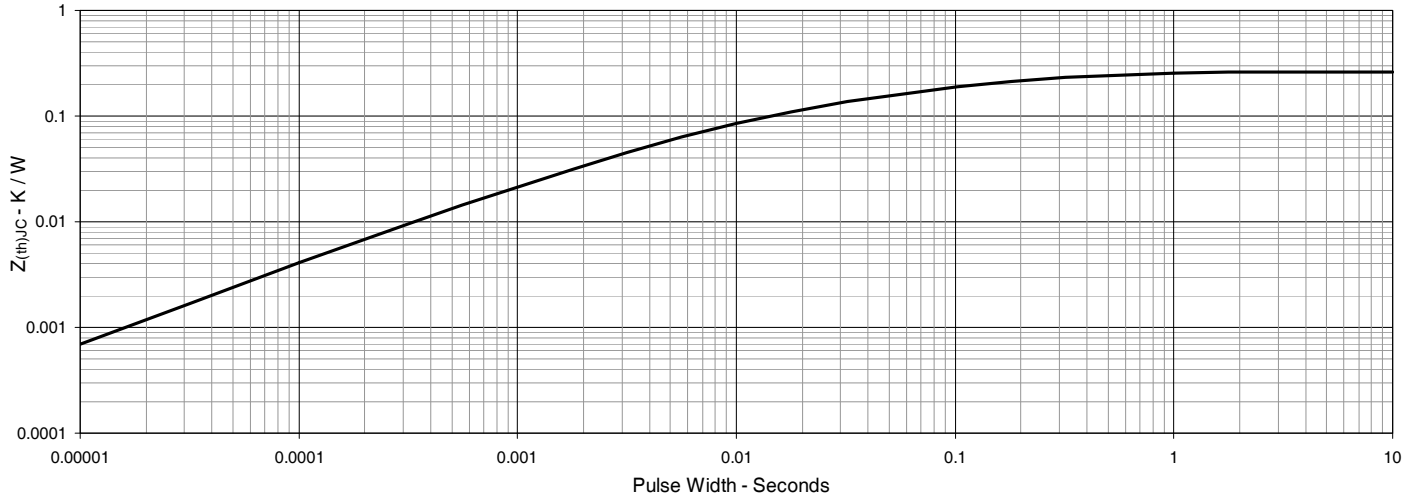


Fig. 12. Inductive Switching Energy Loss vs. Gate Resistance

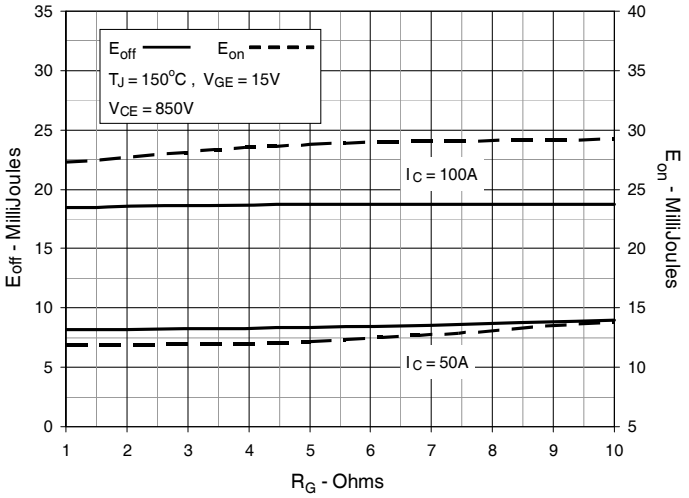


Fig. 13. Inductive Switching Energy Loss vs. Collector Current

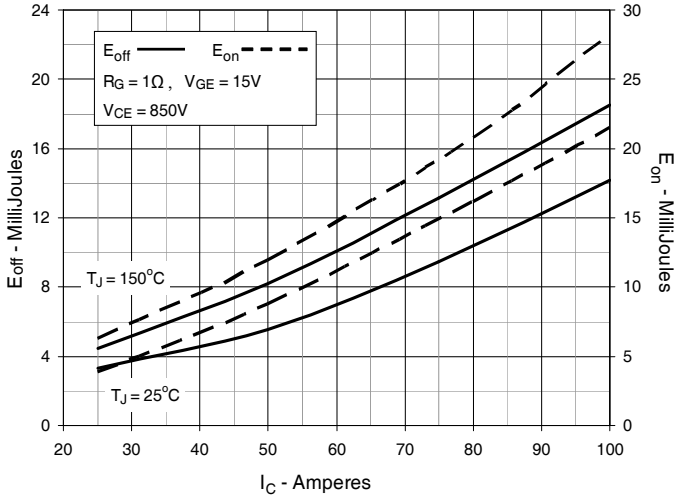


Fig. 14. Inductive Switching Energy Loss vs. Junction Temperature

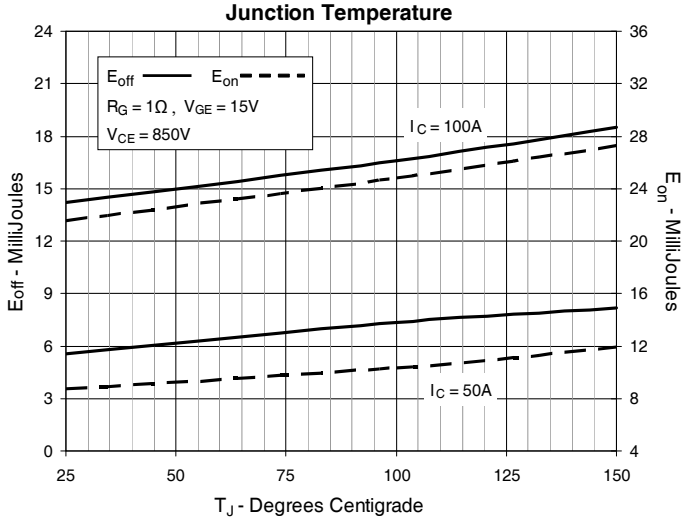


Fig. 15. Inductive Turn-off Switching Times vs. Gate Resistance

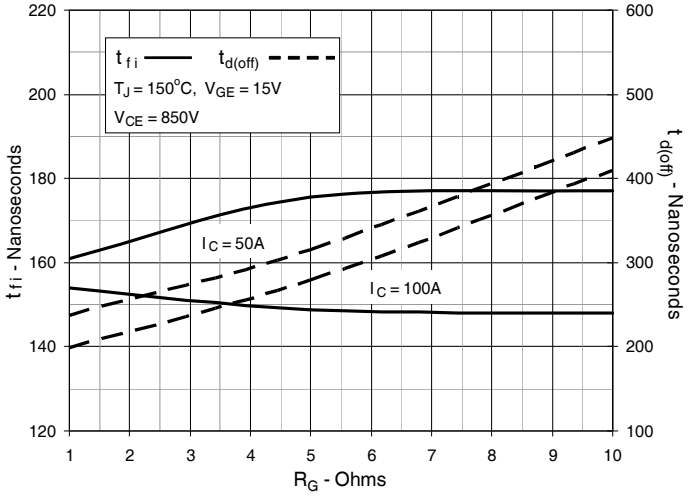


Fig. 16. Inductive Turn-off Switching Times vs. Collector Current

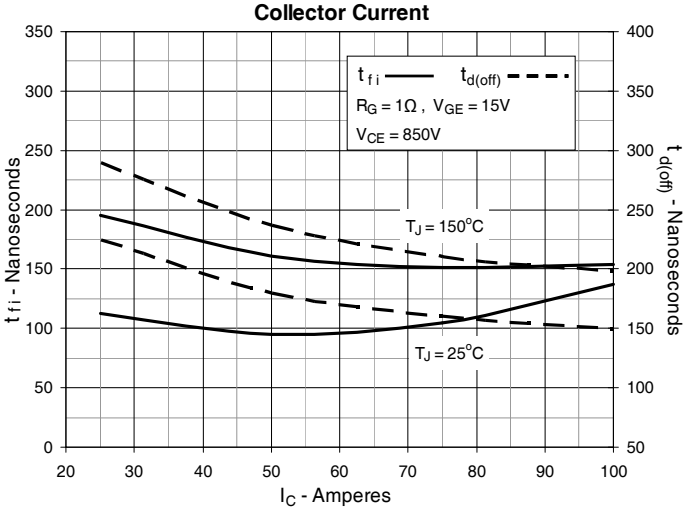


Fig. 17. Inductive Turn-off Switching Times vs. Junction Temperature

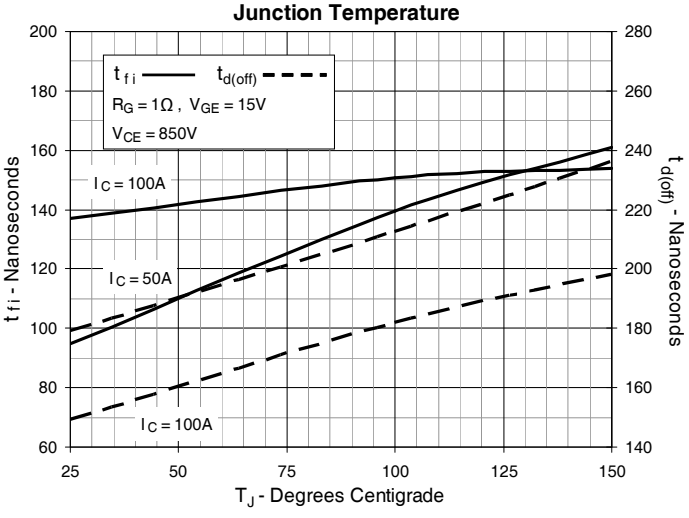


Fig. 19. Inductive Turn-on Switching Times vs. Gate Resistance

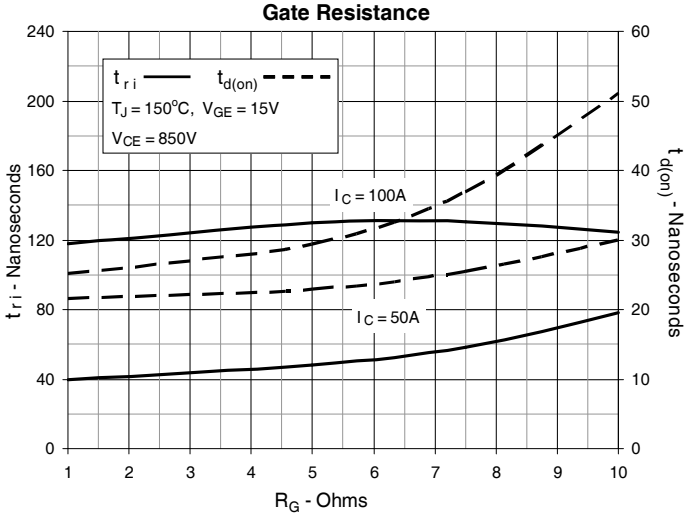


Fig. 20. Inductive Turn-on Switching Times vs. Collector Current

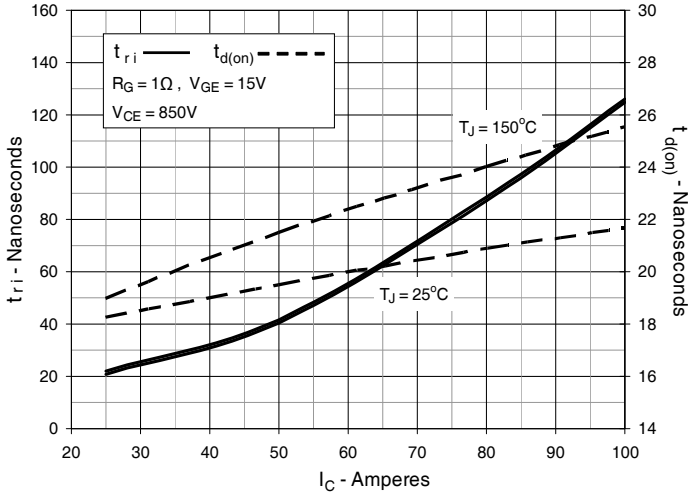


Fig. 21. Inductive Turn-on Switching Times vs. Junction Temperature

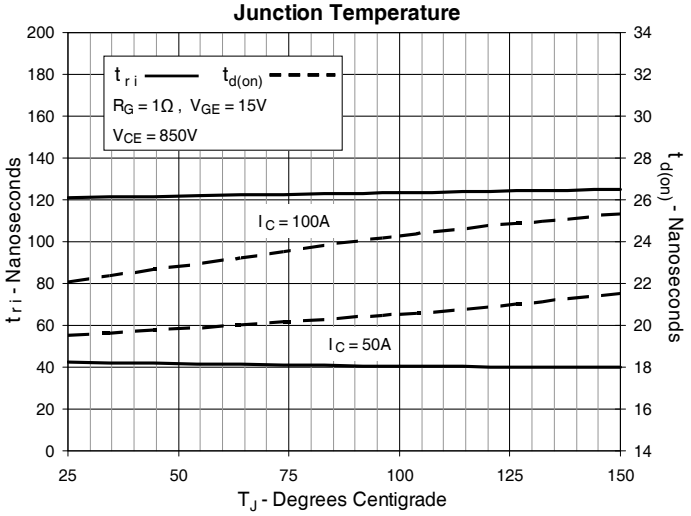


Fig. 22. Diode Forward Characteristics

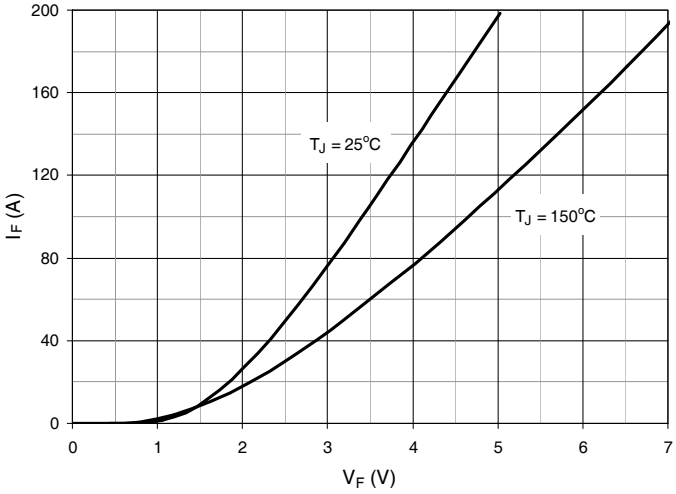


Fig. 23. Reverse Recovery Charge vs. -di$_F$/dt

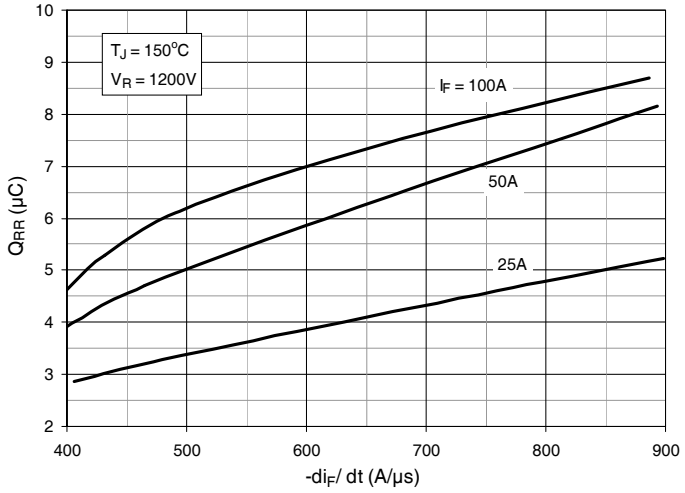


Fig. 23. Reverse Recovery Current vs. -di$_F$/dt

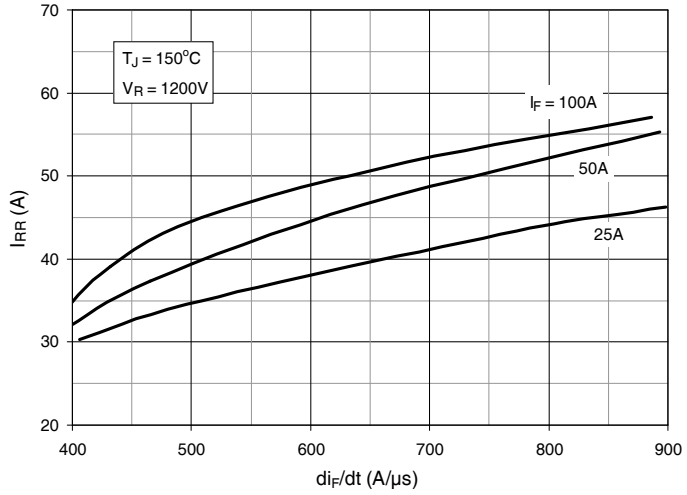


Fig. 24. Reverse Recovery Time vs. -di$_F$/dt

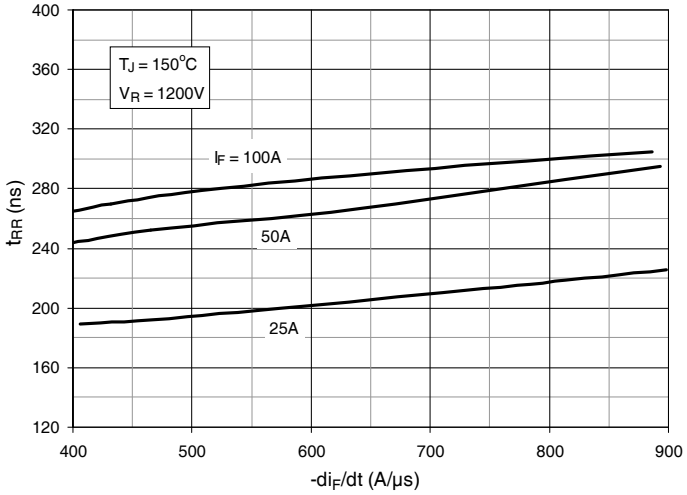


Fig. 25. Dynamic Parameters Q_{RR}, I_{RR} vs. Junction Temperature

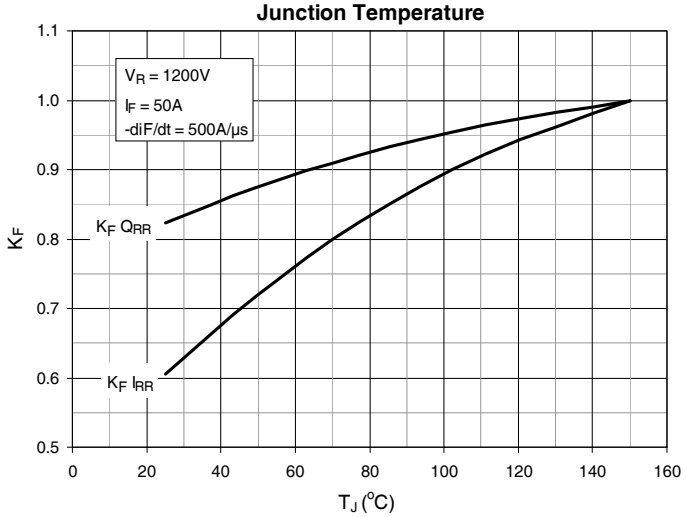
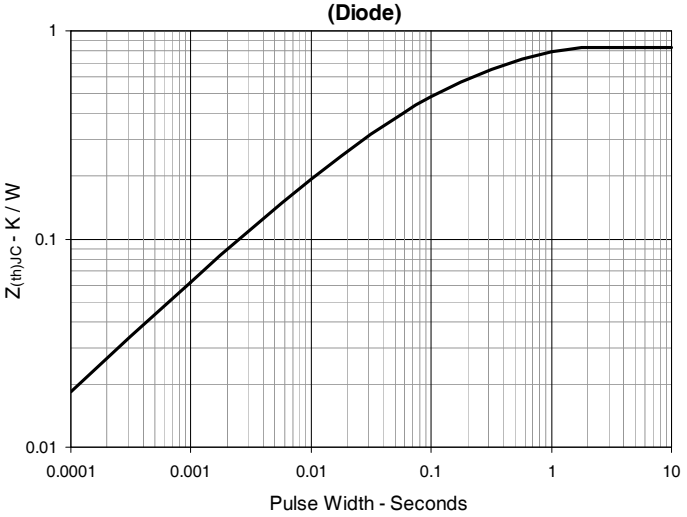
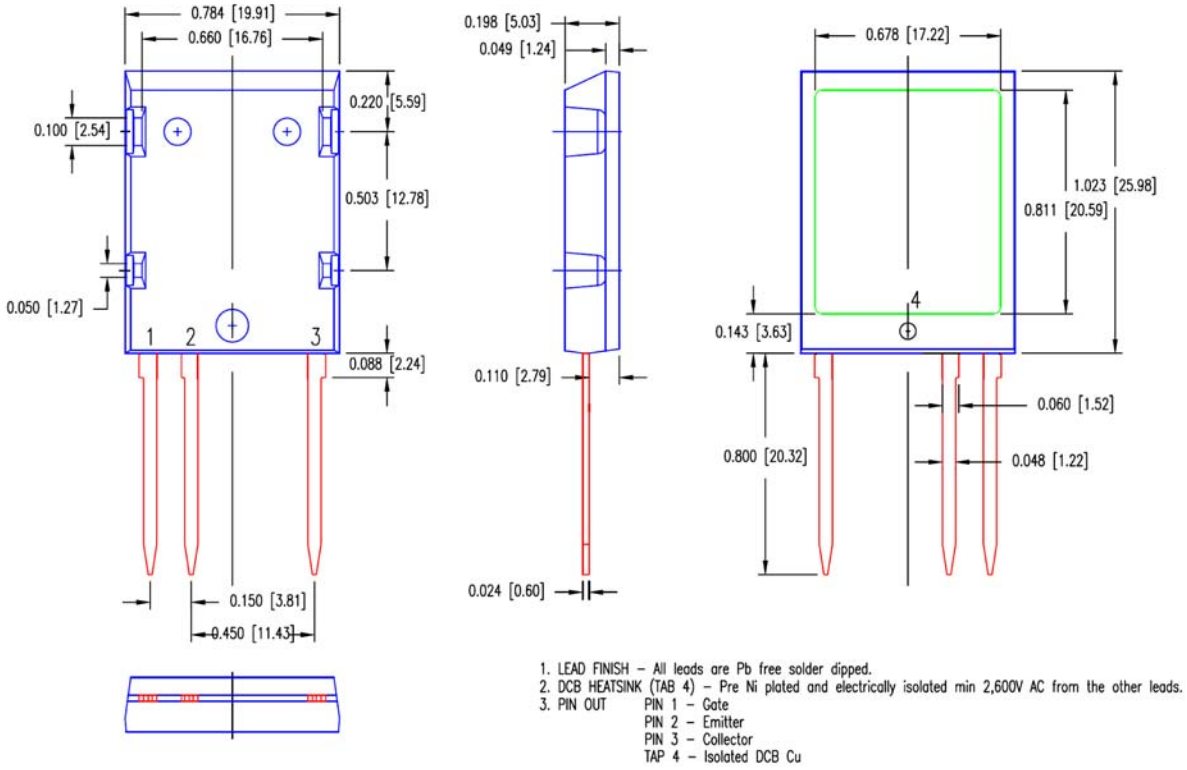


Fig. 26. Maximum Transient Thermal Impedance (Diode)



ISOPLUS i5-Pak™ (IXYL) Outline



1. LEAD FINISH – All leads are Pb free solder dipped.
2. DCB HEATSINK (TAB 4) – Pre Ni plated and electrically isolated min 2,600V AC from the other leads.
3. PIN OUT
   PIN 1 – Gate
   PIN 2 – Emitter
   PIN 3 – Collector
   TAP 4 – Isolated DCB Cu